



NIS-Elements is the total imaging solution for your research

Nikon's universal software platform, NIS-Elements, combines powerful image acquisition, analysis, visualization and data sharing tools. With fully customizable user interfaces and software modules, NIS-Elements can serve as a simple interface for photo-documentation and also power complex, conditional workflows with automated imaging and analysis routines. Graphical programming tools enable users to easily create custom analysis and acquisition workflows.

Triggering

6D Acquisition

Super-Resolution

3D Visualization

Time-Lapse



| Confocal | Tracking | Florochto |
|-----------------------|-----------------------|--------------------------|
| Large Image Stitching | Deconvolution | Elements |
| Volume Analysis | TIRF | Photostimulation |
| Digital I/O | Clinical Applications | Ca ²⁺ Imaging |
| High Content Analysis | Multiphoton | Optogenetics |

One software platform for all imaging systems

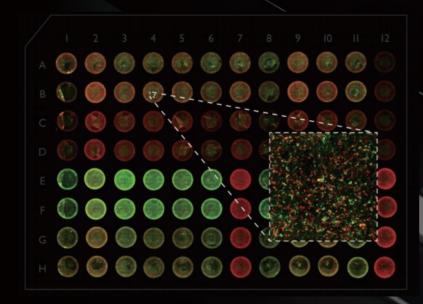
Nikon believes that having a single software platform for all imaging modalities is vital. NIS-Elements provides the same interface, control, workflow, and terminology whether it's used for widefield, confocal, or super resolution imaging. With one platform to learn, users can easily switch between microscope systems when their applications require different imaging modalities. Imaging results from different Nikon systems can also be easily combined and analyzed to expand your research direction.



Total acquisition-to-analysis solution for high-throughput screening assay

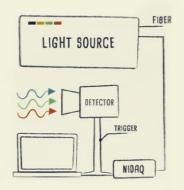
The NIS-Elements HC (High-Content Analysis) provides streamlined high-speed, automated well-plate acquisition, data review, analysis and management for multiple well-plate experiments.

The HC interface simplifies experiment setups using setup wizards. Users can easily define acquisition parameters including well-plate configuration, plate handling, autofocusing, filter switching and detectors.

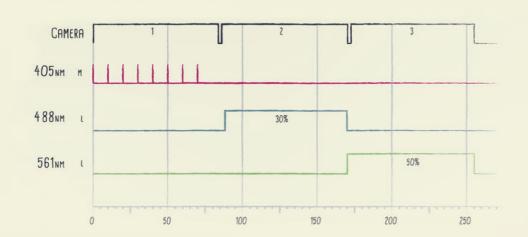


Completely customize to your research

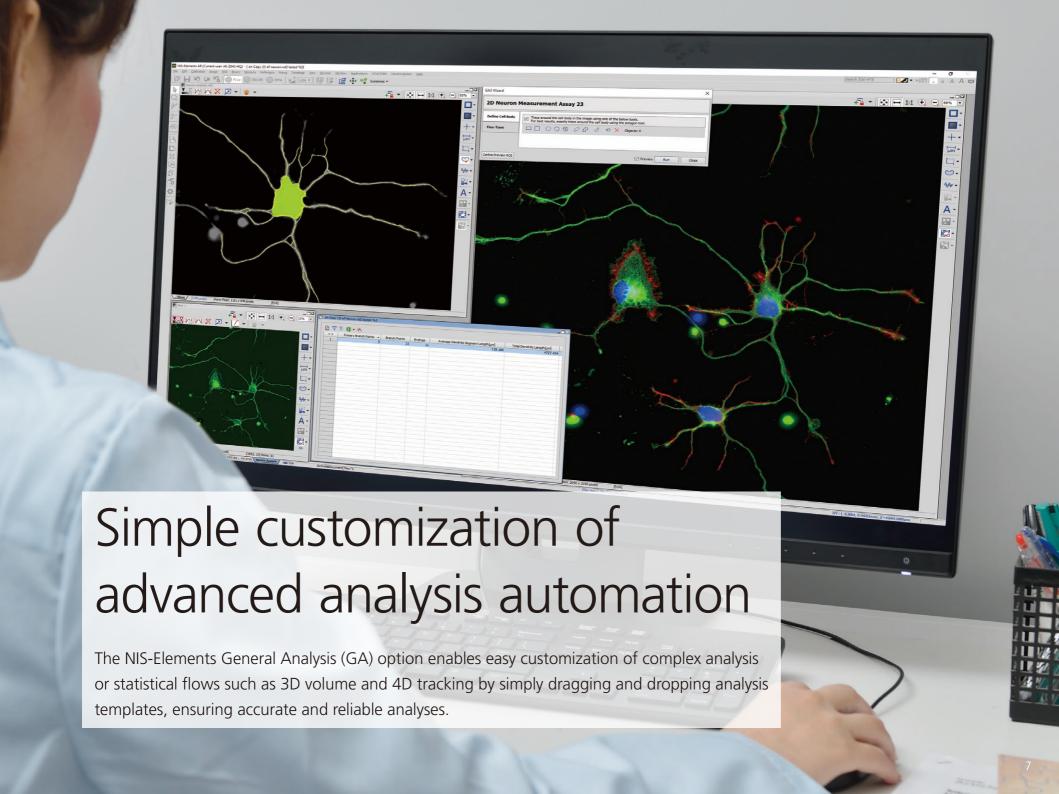
From individual hardware selection and optimization to fine-tuning acquisitions routines and custom multi-channel binary analysis - you are in complete control of tailoring and creating a system built and inspired by your imagination.



| LASER LINES | 405NM | 488NM | |
|-------------|-------|--------|--|
| | | 100111 | |
| | 5% | | |
| | | 30% | |
| | | | |
| | | | |
| | | GREEN | |











Evolves with your research

The software is on the move, always transforming with the demands of research. With NIS-Elements, you can continue to grow your system over time (e.g. upgrade the detector, add additional detectors, change light sources, add a confocal, add high-throughput functionality, etc.).



Nikon's flagship NIS-Elements package

Optimized for advanced research applications, Nikon's flagship software package features fully automated image acquisition, advanced device control and powerful analysis and visualization tools.



Standard research application package

Developed for standard research applications such as analysis and photodocumentation of fluorescent imaging, NIS-Elements BR features up to four-dimensional acquisition and advanced device control capabilities.



Photodocumentation/clinical application package

Software package for photo-documentation and clinical applications. Include basic measuring and reporting tools.



Confocal imaging package

Dedicated interface for Nikon's confocal and multiphoton systems, providing easy instrument setup and streamlined operation. Incorporates many of the features of NIS-Elements AR for advanced acquisition, image processing, analysis, visualization and data sharing capability.



Confocal resolution enhancement

Higher resolution confocal images can be easily generated with a single click. The software assesses the captured image and automatically determines processing parameters to achieve enhanced resolution.



High Content Analysis

Total acquisition-to-analysis solution for high-content imaging applications. Seamless workflow from microscope and peripheral device control to data analysis and management.

Package Comparison

| | CAPTURE | Ar | Br | D | С | ER | HC |
|--------------------------|--|--------|----------|---|--------|--------|--------|
| Confocal support | | | | | ✓ | ✓ | option |
| | Time Lapse | ✓ | √ | ✓ | ✓ | ✓ | ✓ |
| | Z-Stack* | ✓ | ✓ | ✓ | ✓ | ✓ | ✓ |
| Multidimensional Imagina | Multi Point* | ✓ | √ | ✓ | ✓ | 1 | ✓ |
| Multidimensional Imaging | Multichannel* | ✓ | √ | | ✓ | ✓ | ✓ |
| | 4D with Experimental Preview | | option | | | | |
| | 6D with Experimental Preview | option | | | ✓ | 1 | ✓ |
| | AVI Acquisition | ✓ | √ | ✓ | ✓ | 1 | ✓ |
| | JOBS Acquisition | option | | | option | option | option |
| | Simultaneous Dual / Triple / Quad Camera | option | | | option | option | option |
| Acquisition | Triggered Device Control | option | | | option | option | option |
| | DAQ (TTL/ Analog) Control | option | option | | option | option | option |
| | Incubation | option | option | | option | option | option |
| | Volume Contrast | option | | | option | option | option |

^{*} Note: Drivers for third party device control/automation are required.

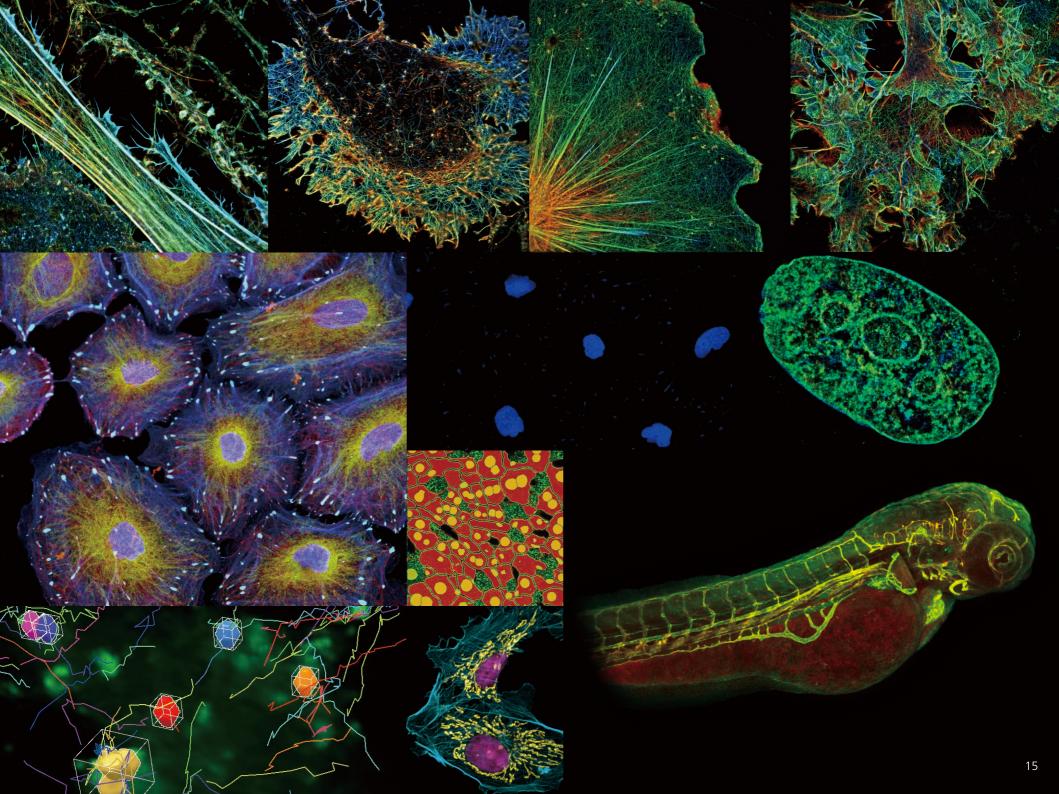
| DISPLAY & PROCESSING | | Ar | Br | D | С | ER | НС |
|----------------------|---------------------------|----------|----------|---|---|----|--------|
| Image | Annotation | ✓ | ✓ | ✓ | ✓ | 1 | ✓ |
| | Image Filters, Morphology | ✓ | | | ✓ | 1 | ✓ |
| | Image Arithmetic | √ | 1 | | ✓ | 1 | ✓ |
| | Denoise.ai | | | | ✓ | 1 | option |

| DISPLAY & PROCESSING | | Ar | Br | D | С | ER | HC |
|---------------------------------------|--|--------|----------|--------|--------|----------|----|
| Image layers | Multi-dimensional image viewer | ✓ | ✓ | ✓ | 1 | 1 | ✓ |
| | Binary Layers | ✓ | ✓ | option | 1 | ✓ | ✓ |
| 2D/3D image creation | Snapshot | ✓ | ✓ | ✓ | ✓ | ✓ | ✓ |
| | Movie | ✓ | ✓ | ✓ | 1 | ✓ | ✓ |
| | Interactive Movie / Volume Rendering | ✓ | ✓ | | 1 | ✓ | ✓ |
| | Tiling (Montage) View | ✓ | ✓ | ✓ | ✓ | ✓ | ✓ |
| | Max / Min Projections | ✓ | ✓ | | ✓ | ✓ | ✓ |
| Interactive | Ratio Viewing and Graphing | ✓ | | | 1 | ✓ | ✓ |
| image display / Image manipulation | Plate View, Heat Maps, Sample Labeling | option | | | option | option | ✓ |
| | Volume View: 3D ND Crop | ✓ | ✓ | | 1 | ✓ | ✓ |
| | Manual Channel Alignment | 1 | 1 | 1 | 1 | ✓ | 1 |

| CAPTURE, DISPLAY & MULTIFUNCTION | | Ar | Br | D | С | ER | HC |
|----------------------------------|---------------------------------------|--------|--------|--------|--------|----------|--------|
| | Live Compare | ✓ | option | option | ✓ | ✓ | ✓ |
| | HDR (High Dynamic Range) | ✓ | option | option | ✓ | ✓ | ✓ |
| Multi functional imaging | EDF / Real Time EDF | option | option | option | option | option | option |
| | 2D Large Image Stitching (Free shape) | ✓ | ✓ | 1 | 1 | ✓ | ✓ |
| | 3D Large Image Stitching (Free shape) | ✓ | ✓ | | ✓ | ✓ | ✓ |
| | FRET/Custom Equation Editor | option | | | option | option | option |
| | Deconvolution (2D Real Time/2D/3D) | option | | | option | ✓ | option |
| Macro | Macro Creation | ✓ | ✓ | 1 | 1 | ✓ | ✓ |
| IVIACIO | Macro Debugger & Variable View | ✓ | option | option | ✓ | ✓ | ✓ |
| User management | Multi-User Environment | ✓ | ✓ | ✓ | ✓ | ✓ | ✓ |

| CAPTURE, DISPLAY & MULTIFUNCTION | | Ar | Br | D | С | ER | НС |
|----------------------------------|-------------------------|--------|--------|--------|--------|--------|--------|
| Database | High Content Database | option | | | option | option | ✓ |
| | Image Database (non HC) | option | option | option | option | option | option |
| Report | Report Generator | ✓ | 1 | 1 | ✓ | ✓ | ✓ |

| | MEASUREMENT | Ar | Br | D | С | ER | НС |
|-------------------------------|---|--------|--------|--------|--------|--------|--------|
| General measurement | Segmentation | ✓ | ✓ | | ✓ | 1 | ✓ |
| | Auto-Measurement | ✓ | ✓ | option | ✓ | 1 | ✓ |
| | ROI(Region of Interest) Tools & Statistics | ✓ | ✓ | | 1 | 1 | ✓ |
| | Time-Measurement | ✓ | option | | ✓ | ✓ | ✓ |
| | Volume Measurement | ✓ | | | ✓ | ✓ | ✓ |
| Multi-dimentional measurement | 3D Volume Measurements | option | | | option | option | option |
| | Z profile & 3D EDF Measurements | option | option | option | option | option | option |
| | Kymograph | ✓ | | | ✓ | ✓ | ✓ |
| Tracking | 2D/3D Object Tracking | option | | | option | option | option |
| | Pixel Classifier | ✓ | ✓ | ✓ | ✓ | ✓ | ✓ |
| Classifier | Object Classifier-Advanced Segmentation | option | | | option | option | option |
| | Colocalization | ✓ | | | 1 | 1 | ✓ |
| | Live/Dead | option | | | option | option | ✓ |
| High content | High Content Intensity Image | option | | | option | option | ✓ |
| | Cell Counting | option | | | option | option | ✓ |
| | General Analysis (Automated image analysis) | option | | | option | option | ✓ |
| Industrial | Grain Sizing, Cast Iron & Filter Analysis | option | option | option | option | option | option |



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